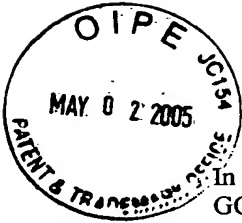


STW



PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the application of:  
GOTKIS et al.

Application No.: 10/749,531

Filed: December 30, 2003

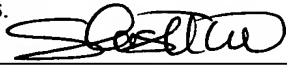
For: METHOD AND APPARATUS OF ARRAYED,  
CLUSTERED OR COUPLED EDDY CURRENT  
SENSOR CONFIGURATION FOR MEASURING  
CONDUCTIVE FILM PROPERTIES

)  
)  
) Group Art Unit: 1763  
)  
) Examiner: Unassigned  
)  
) Docket No. LAM2P455  
)  
) Date: April 28, 2005  
)  
)

CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service as First Class Mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450 Alexandria, VA 22313-1450 on April 28, 2005.

Signed: \_\_\_\_\_

  
Sylvia Castillo

INFORMATION DISCLOSURE STATEMENT

Mail Stop Amendment  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

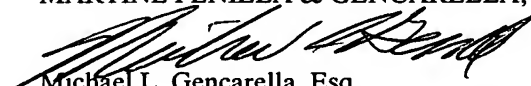
Dear Sir:

The references listed in the attached PTO Form 1449, (the copies of references which are not U.S. Patents have been attached), may be material to examination of the above-identified patent application. Applicants submit these references in compliance with their duty of disclosure pursuant to 37 CFR §§ 1.56 and 1.97. The Examiner is requested to consider these references and to acknowledge such consideration by initialing the attached PTO Form 1449 at the appropriate locations.

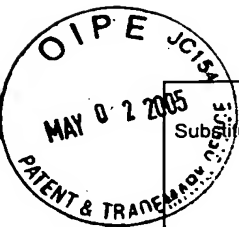
This Information Disclosure Statement (IDS) is not to be construed as a representation that a search has been made, that additional information material to the examination of this application does not exist, or that these references indeed constitute prior art.

Applicants state that each item of information listed in the attached PTO Form 1449 was cited in a communication in a counterpart international application not more than three months prior to the filing of this statement. For the Examiner's use and information, a copy of the International Search Report in the corresponding international application is attached. In the event any fees are due to effect consideration of the references, the Commissioner is hereby authorized to charge such fees to Deposit Account 50-0805 (Order No. LAM2P455).

Respectfully submitted,  
MARTINE PENILLA & GENCARELLA, LLP

  
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Reg. No. 44,703

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Sunnyvale, CA 94085  
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Customer Number 25920



Substitute for form 1449/PTO  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> <i>(Use as many sheets as necessary)</i>		<b>Complete if Known</b>			
		Application Number	10/749,531		
		Filing Date	December 30, 2003		
		First Named Inventor	GOTKIS et al.		
		Art Unit	1763		
Examiner Name	Unassigned				
Sheet	1	of	1	Attorney Docket Number	LAM2P455

### U.S. Patent Documents

Examiner Initials	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			
	A	2003/06620 A1	04/10/03	Hellstrom	
	B	6,808,590	10/26/04	Gotkis et al.	
	C				
	D				
	E				
	F				
	G				

### Foreign Patent Documents

Examiner Initial	Cite No. <sup>1</sup>	Foreign Patent Document No.	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>
		Country Code <sup>3</sup> -Number- <sup>4</sup> Kind Code <sup>5</sup> (if known)				
	I	GB 1 452 417	10/13/76	Leybold Heraeusverwal Tung GMBH		<input type="checkbox"/>
	J	DE 42 27 735 A1	02/24/94	Leybold AG, 63450 Hanau, DE		<input type="checkbox"/>
	K	WO 91/15733	10/17/91	Micro-Epsilon Messtechnik GMBH & Co. KG		<input type="checkbox"/>
	L					<input type="checkbox"/>
	M					<input type="checkbox"/>

### Non Patent Literature Documents

Examiner Initial	Cite No.	Include name of author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published
	N	
	O	
	P	
	Q	

Examiner Signature		Date Considered	
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Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

<sup>1</sup>Applicant's unique citation designation number (optional). <sup>2</sup>See Kinds Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04. <sup>3</sup>Enter Office that issued the document, by two-letter code (WIPO Standard ST.3). <sup>4</sup>For Japanese patent documents, the indication of the year of the reign of Emperor must precede the serial number of the patent document. <sup>5</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup>Applicant is to place a check mark here if English language translation is attached.